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Application/Control No.	Applicant(s)/Patent under Reexamination
10/606,699	MEIRI ET AL.
Examiner	Art Unit
Yaima Campos	2185

	SEARCHED		
Class	Subclass	Date	Examiner
711	113	1/30/2007	YC
711	118	1/30/2007	YC
711	135	1/30/2007	YC
711	141	1/30/2007	YC
711	154	.1/30/2007	YC
711	161	1/30/2007	YC
711	162	1/30/2007	YC
707	203	1/30/2007	YC
707	204	1/30/2007	YC

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Class	Subclass	Date ·	Examiner
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Updated EAST text search	1/30/2007	YC
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